Datasheet

ABB FTIR – FTLA2000 Analyzer Driver/Interface

This document describes the driver/interface for the ABB FTIR - FTLA2000 series laboratory analyzers.

Product Description

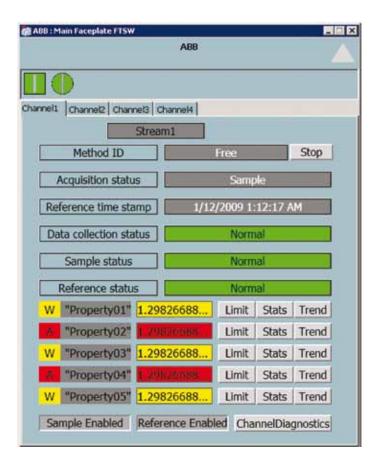
The interface provides data collection and control of all instrument parameters. This allows acquisition of reference (also called background) and sample spectra.

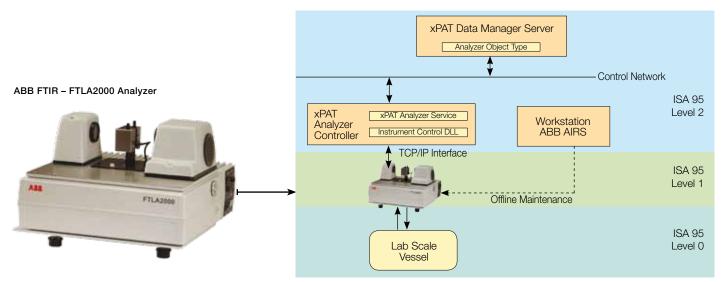
The interface is compatible with all ABB FTLA2000 and MB100 series spectrometers that use an Ethernet Interface. This includes Mid IR models FTLA2000-100, FTLA2000-104, Near IR models FTLA2000-154 and FTLA2000-160. It is not compatible with earlier MB series spectrometers that require an ISA or PCI bus interface card to be placed in the PC.

The software interface is made up of an instrument control DLL that interfaces to the analyzer hardware, the xPAT analyzer service, the xPAT configuration template for FTLA2000 and the xPAT object type for FTLA2000.

ABB's AIRS software is used to initially qualify the analyzer and to validate its correct operation. AIRS is not required for routine operation of the analyzer.

Manual control and status display of the analyzer is provided by a standard faceplate associated with each instance of the analyzer on the xPAT workplace.







Specifications						
Analyzer Class	IR spectrom	IR spectrometer: FTLA2000-100 and FTLA2000-104				
	NIR spectrometer: FTLA2000-154 and FTLA2000-160					
Subclass	Fourier Tran	Fourier Transform Spectrometer (FTIR/FTNIR)				
Interface	Ethernet TC	Ethernet TCP/IP				
Compatibility	All Ethernet	based FTLA200	0/MB Series Analy:	zers		
Throughput	Mid IR models Near IR models					
	Resolution	Spectrum size	Max samples	Spectrum size	Max samples	
	1 cm ⁻¹	16384	every 32 secs	32768	every 64 secs	
	2 cm ⁻¹	8192	every 16 secs	16384	every 32 secs	
	4 cm ⁻¹	4096	every 8 secs	8192	every 16 secs	
	8 cm ⁻¹	2048	every 5 secs	4096	every 8 secs	
	16 cm ⁻¹	1024	every 5 secs	2048	every 5 secs	
	32 cm ⁻¹	512	every 5 secs	1024	every 5 secs	
	64 cm ⁻¹	256	every 5 secs	512	every 5 secs	
	128 cm ⁻¹	128	every 5 secs	256	every 5 secs	
Control Parameters		s to all paramete		200	every e deed	
Channels		1 Channel				
Gains						
•		1 Stage gain set by switch, no software control Selectable 1,2,4,8,16,32,64,128 cm ⁻¹ only manual selection by switch available on early models				
Spectral Resolution						
Signal Processing Parameters		Settings for signal processing of raw data				
Laser Frequency		Determines the x axis of the spectrum; Default 15799.70 cm ⁻¹				
Interferogram Apodization Function		Selectable: Boxcar, Bartlet, Cosine, Hamming, Blackman-Harris, Gaussian,				
(sample and phase correction)		Norton Beer Weak, Norton Beer Medium, Norton Beer Strong				
Phase Correction Resolution		Selectable 64, 128, 256, 512 cm ⁻¹ ; Default 128 cm ⁻¹				
Spectral Range	Not selectal	ole, always uses	maximum range			
Faceplate Status Indicators – analyzer						
Connection Status	Status of Et	Status of Ethernet link to analyzer: good or bad				
Analyzer Status	Status of an	Status of analyzer: good or bad				
Faceplate Status Indicators per channe	<u> </u>					
Acquisition Status	Idle, Sample	Idle, Sample Starting, Sample, Reference Starting or Reference				
Reference Time Stamp	Data time fo	Data time for last Reference				
Data Collection Status	Normal, Ma	intenance, Fault				
(for sample or reference)						
Faceplate Commands per channel	Collect Sam	Collect Sample, Collect Reference				
Control Type	xPAT provid	xPAT provides start/stop signal				
Data Acquisition	Collect Refe	Collect Reference Spectrum for Calibration and Absorbance Spectrum for samples				
Data Analysis	Up to 5 prop	Up to 5 properties with Prediction Statistics computed from Peak height or PLS model (PLSplusIQ or SimcaP+				
Calibration	Collect Refe	Collect Reference				
Validation	Operational Qualification (OQ) of analyzer partly supported in spectral diagnostics; full OQ requires AIRS					
	software. Performance Qualification (PQ) implemented by method specific configuration					
Spectral Diagnostics	Available on Reference and Sample spectra: Spectral Noise (RMS noise over a spectral					
	region), Frequency Validation (check correct location of a known band), Non-linearity					
	(detect saturation with out of band signal), Spectral Band Intensity (Check a band for minimum intensity)					
Health Monitoring		Monitors Analyzer Hardware Status; e.g. TCP/IP connection to Analyzer, Bad Scan Detection				
Asset Management		Not implemented				

For more information on the FTLA2000 analyzer itself please visit www.abb.com/ analytical. For more information on ABB Life Sciences solutions visit www.abb.com/lifesciences.

Note:

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